

Notice of References Cited	Application/Control No. 10/721,663	Applicant(s)/Patent Under Reexamination LO, WEI-LUN	
	Examiner Navneet K. Ahluwalia	Art Unit 2166	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0025117 A1	02-2004	Ingersoll et al.	715/523
*	B	US-2004/0268244 A1	12-2004	Levanoni et al.	715/514
*	C	US-2002/0161801 A1	10-2002	Hind et al.	707/513
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	M	US-			

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NON-PATENT DOCUMENTS

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